

UNISONIC TECHNOLOGIES CO., LTD

14N50 **Preliminary Power MOSFET**

14A, 500V N-CHANNEL POWER MOSFET

DESCRIPTION

The UTC 14N50 is an N-Channel enhancement mode power MOSFET. The device adopts planar stripe and uses DMOS technology to minimize and provide lower on-state resistance and faster switching speed. It can also withstand high energy pulse under the avalanche and commutation mode conditions.

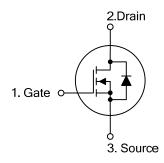
The UTC 14N50 is ideally suitable for high efficiency switch mode power supply, power factor correction and electronic lamp ballast based on half bridge topology.



FEATURES

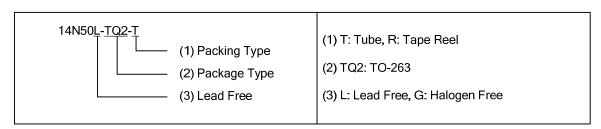
- * $R_{DS(ON)} = 0.38\Omega @V_{GS} = 10V$
- * Ultra low gate charge (typical 43nC)
- * Low reverse transfer Capacitance (C_{RSS} = typical 20pF)
- * Fast switching capability
- * Avalanche energy tested
- * Improved dv/dt capability, high ruggedness

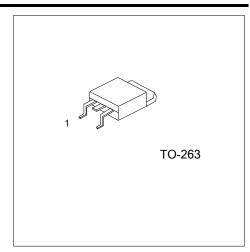
SYMBOL



ORDERING INFORMATION

Ordering Number		Dookogo	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
14N50L-TQ2-T	14N50G-TQ2-T	TO-263	G	D	S	Tube	
14N50L-TQ2-R	14N50G-TQ2-R	TO-263	G	D	S	Tape Reel	





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■ ABSOLUTE MAXIMUM RATINGS (T_C = 25°C, unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT
Drain-Source Voltage	V_{DSS}	500	V
Gate-Source Voltage	V_{GSS}	±30	V
Continuous Drain Current	I_{D}	14	Α
Pulsed Drain Current (Note 2)	I _{DM}	48	Α
Avalanche Current (Note 2)	I_{AR}	14	Α
Single Pulsed Avalanche Energy (Note 3)	E _{AS}	400	mJ
Peak Diode Recovery dv/dt (Note 4)	dv/dt	4.5	V/ns
Power Dissipation (T _C =25°C)	P_D	150	W
Junction Temperature	TJ	+150	°C
Storage Temperature	T_{STG}	-55~+150	°C

- Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

 Absolute maximum ratings are stress ratings only and functional device operation is not implied.
 - 2. Repetitive Rating : Pulse width limited by maximum junction temperature
 - 3. L = 9.3mH, I_{AS} = 13A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25 $^{\circ}$ C
 - 4. $I_{SD} \le 13.A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	θ_{JA}	62.5	°C/W
Junction to Case	θ_{JC}	0.83	°C/W

■ **ELECTRICAL CHARACTERISTICS** (T_C =25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage	BV _{DSS}	V_{DSS} $V_{GS} = 0V$, $I_D = 1mA$				V		
Drain-Source Leakage Current	I _{DSS}	V _{DS} = 500V, V _{GS} = 0V			10	μΑ		
Gate-Source Leakage Current	I _{GSS}	$V_{GS} = 20V, V_{DS} = 0V$			100	nA		
		$V_{GS} = -20V, V_{DS} = 0V$			-100	nA		
Breakdown Voltage Temperature Coefficient	$\triangle BV_{DSS}/\triangle T_{J}$	I _D =250mA,Referenced to 25°C		0.5		V/°C		
ON CHARACTERISTICS								
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_{D} = 100 \mu A$	3	3.75	4.5	V		
Static Drain-Source On-State Resistance	R _{DS(ON)}	$V_{GS} = 10V, I_D = 6A$		0.34	0.38	Ω		
DYNAMIC CHARACTERISTICS								
Input Capacitance	C _{ISS}	V _{DS} =25V, V _{GS} =0V, -f=1.0MHz		2000		pF		
Output Capacitance	Coss			238		pF		
Reverse Transfer Capacitance	C _{RSS}			55		pF		
SWITCHING CHARACTERISTICS								
Turn-On Delay Time	t _{D(ON)}			24		nS		
Turn-On Rise Time	t _R	V_{DD} =250V, I_{D} =14A, R_{G} =25 Ω (Note 1,2)		16		nS		
Turn-Off Delay Time	t _{D(OFF)}			54		nS		
Turn-Off Fall Time	t _F			12		nS		
Total Gate Charge	Q_{G}	V _{DS} =400V, I _D =12A, -V _{GS} =10 V (Note 1,2)		69	92	nC		
Gate-Source Charge	Q_{GS}			12		nC		
Gate-Drain Charge	Q_{GD}			31		nC		

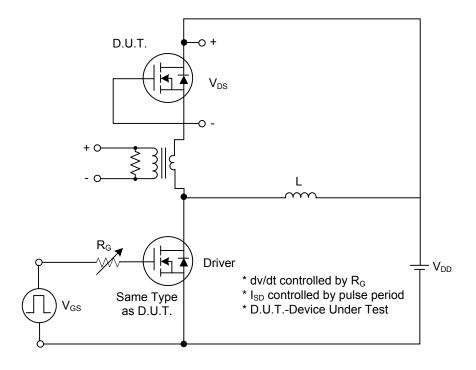
■ ELECTRICAL CHARACTERISTICS(Cont.)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS								
Drain-Source Diode Forward Voltage	V_{SD}	$V_{GS} = 0V, I_{S} = 13 A$			1.6	V		
Maximum Continuous Drain-Source Diode Forward Current	Is				12	Α		
Maximum Pulsed Drain-Source Diode Forward Current	I _{SM}				48	Α		
Reverse Recovery Time	t _{rr}	$V_{GS} = 0V, I_{S} = 13A,$		470		nS		
Reverse Recovery Charge	Q_{RR}	dI _F / dt =100A/μs (Note 1)		3.1		иC		

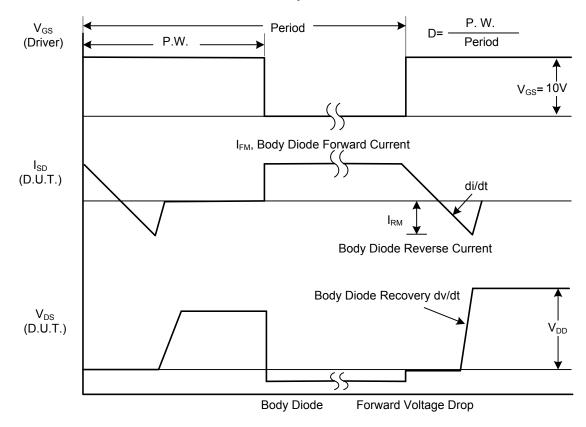
Note: 1. Pulse Test : Pulse width≤300µs, Duty cycle≤2%

2. Essentially independent of operating ambient temperature

TEST CIRCUITS AND WAVEFORMS

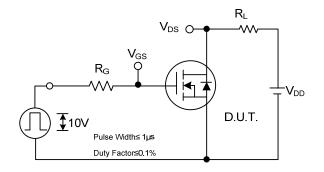


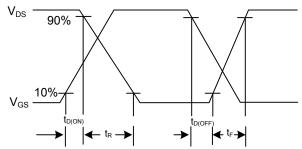
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

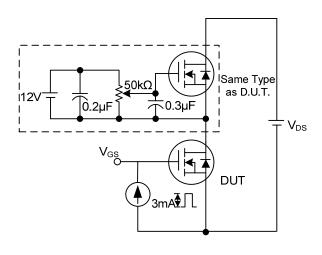
■ TEST CIRCUITS AND WAVEFORMS (Cont.)

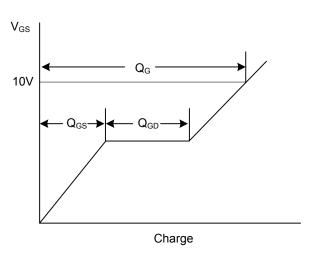




Switching Test Circuit

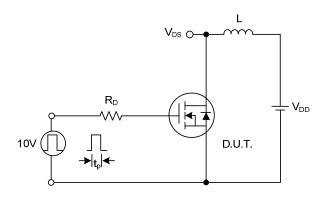
Switching Waveforms

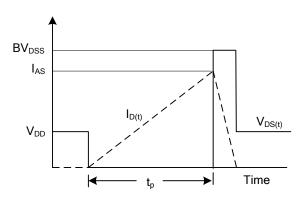




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

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